

Form PTO 1449 (Modified)		U.S. DEPARTMENT O PATENT AND TRADE		204838US3 CONT			New Cont. Application		
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LIST OF REFERENCES CITED BY APPLICANT				Yukio KOHMURA					
				FILING DATE Herewith			GROUP		
				J.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME		CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
CL	AA	4,726,764	2/23/88	Yoshikai		_			
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		DOCUMENT NUMBER	DATE	COUNTRY Class Sides		Silasi	TRANSLATION YES NO		
a	AO	6-127964	5/10/94	Japan (w/ English Abstract)	\ ~	100		X	
	AP	4-21535	1/24/92	Japan (w/ English Abstract)	_	_		X	
	AQ	5-66092	3/19/93	Japan (w/ English Abstract)	1-			X	
	AR	61-26531	2/5/86	Japan (w/ English Abstract)	1-	1-		X	
11	AS	3-159932	<u> </u>	Japan (w/ English Abstract)		1-		Х	
64	AT	61-270231	11/29/86	Japan (w/ English Abstract)		_[ _		X	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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*Examiner: Ini conformance a	Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								